

ICX418AKL

Diagonal 8mm (Type 1/2) CCD Image Sensor for NTSC Color Video Cameras

Description

The ICX418AKL is an interline CCD solid-state image sensor suitable for NTSC color video cameras with a diagonal 8mm (Type 1/2) system. Compared with the current product ICX038DNA, basic characteristics such as sensitivity, smear, dynamic range and S/N are improved drastically.

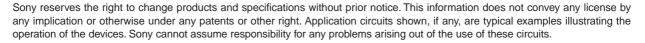
This chip features a field period readout system and an electronic shutter with variable charge-storage time. This chip is compatible with the pins of the ICX038DNA and has the same drive conditions.

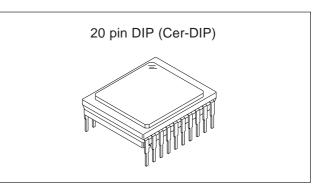
Features

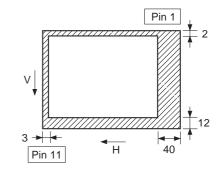
- High sensitivity (+6.0dB compared with the ICX038DNA)
- Low smear (-5.0dB compared with the ICX038DNA)
- High D range (+2.0dB compared with the ICX038DNA)
- High S/N
- High resolution and low dark current
- Excellent antiblooming characteristics
- Ye, Cy, Mg, and G complementary color mosaic filters on chip
- Continuous variable-speed shutter
- Substrate bias: Adjustment free (external adjustment also possible with 6 to 14V)
- Reset gate pulse: 5Vp-p adjustment free (drive also possible with 0 to 9V)
- Horizontal register: 5V drive

Device Structure

- Interline CCD image sensor
- Optical size: Diagonal 8mm (Type 1/2)
- Number of effective pixels: 768 (H) \times 494 (V) approx. 380K pixels
- Total number of pixels: 811 (H) \times 508 (V) approx. 410K pixels
- Chip size: 7.40mm (H) × 5.95mm (V)
- Unit cell size: $8.4\mu m (H) \times 9.8\mu m (V)$
- Optical black: Horizontal (H) direction: Front 3 pixels, rear 40 pixels
 - Vertical (V) direction: Front 12 pixels, rear 2 pixels
- Number of dummy bits: Horizontal 22
- Vertical 1 (even fields only)
- Substrate material: Silicon







Optical black position (Top View)

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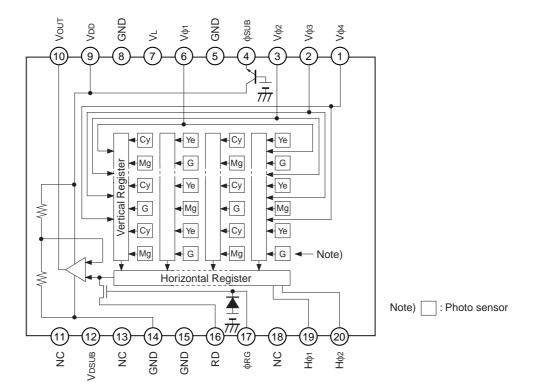
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Block Diagram and Pin Configuration

(Top View)



Pin Description

Pin No.	Symbol	Description	Pin No.	Symbol	Description
1	Vφ4	Vertical register transfer clock	11	NC	
2	Vфз	Vertical register transfer clock	12	Vdsub	Substrate bias circuit supply voltage
3	Vø2	Vertical register transfer clock	13	NC	
4	фѕив	Substrate clock	14	GND	GND
5	GND	GND	15	GND	GND
6	Vφ1	Vertical register transfer clock	16	RD	Reset drain bias
7	VL	Protective transistor bias	17	¢ RG	Reset gate clock
8	GND	GND	18	NC	
9	Vdd	Output circuit supply voltage	19	Ηφ1	Horizontal register transfer clock
10	Vout	Signal output	20	Ηφ2	Horizontal register transfer clock

Absolute Maximum Ratings

	Item	Ratings	Unit	Remarks
Substrate clock	в – GND	-0.3 to +50	V	
Supply voltage	Vdd, Vrd, Vdsub, Vout – GND	-0.3 to +18	V	
Supply voltage	Vdd, Vrd, Vdsub, Vout – φsub	-55 to +10	V	
	Vφ1, Vφ2, Vφ3, Vφ4 – GND	-15 to +20	V	
Clock input voltage	Vφ1, Vφ2, Vφ3, Vφ4 – φsub	to +10	V	
Voltage difference b	between vertical clock input pins	to +15	V	*1
Voltage difference b	etween horizontal clock input pins	to +17	V	
Ηφ1, Ηφ2 – Vφ4		-17 to +17	V	
φrg − GND		-10 to +15	V	
фrg — фsub		-55 to +10	V	
VL – ¢SUB		-65 to +0.3	V	
Pins other than GN	D and φsυв − V∟	-0.3 to +30	V	
Storage temperature	e	-30 to +80	°C	
Operating temperate	ure	-10 to +60	°C	

 $^{*1}\,$ +27V (Max.) when clock width < 10µs, clock duty factor < 0.1%.

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
Output circuit supply voltage	Vdd	14.55	15.0	15.45	V	
Reset drain voltage	Vrd	14.55	15.0	15.45	V	Vrd = Vdd
Protective transistor bias	VL		*1			
Substrate bias circuit supply voltage	Vdsub	14.55	15.0	15.45	V	
Substrate clock	фѕив		*2			

Bias Conditions 1 [when used in substrate bias internal generation mode]

*1 VL setting is the VvL voltage of the vertical transfer clock waveform, or the same supply voltage as the VL power supply for the V driver should be used. (When CXD1267AN is used.)

*2 Do not apply a DC bias to the substrate clock pin, because a DC bias is generated within the CCD.

Bias Conditions 2 [when used in substrate bias external adjustment mode]

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
Output circuit supply voltage	Vdd	14.55	15.0	15.45	V	
Reset drain voltage	Vrd	14.55	15.0	15.45	V	Vrd = Vdd
Protective transistor bias	VL		*3			
Substrate bias circuit supply voltage	Vdsub		*4			
Substrate voltage adjustment range	Vsub	6.0		14.0	V	*5
Substrate voltage adjustment precision	ΔV SUB	-3		+3	%	*5

*3 VL setting is the VvL voltage of the vertical transfer clock waveform, or the same supply voltage as the VL power supply for the V driver should be used. (When CXD1267AN is used.)

- *4 Connect to GND or leave open.
- *5 The setting value of the substrate voltage (Vsub) is indicated on the back of the image sensor by a special code. When adjusting the substrate voltage externally, adjust the substrate voltage to the indicated voltage. The adjustment precision is ±3%. However, this setting value has not significance when used in substrate bias internal generation mode.

Vsub code — one character indication

Code and optimal setting correspond to each other as follows.

Vsub code	E	f	G	h	J	К	L	m	N	Ρ	Q	R	S	Т	U	V	W
Optimal setting	6.0	6.5	7.0	7.5	8.0	8.5	9.0	9.5	10.0	10.5	11.0	11.5	12.0	12.5	13.0	13.5	14.0

<Example> "L" \rightarrow Vsub = 9.0V

DC Characteristics

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
Output circuit supply current	ldd		5.0	10.0	mA	

Clock Voltage Conditions

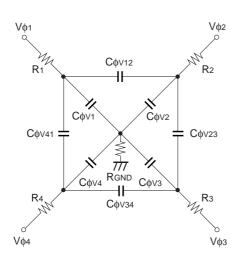
Item	Symbol	Min.	Тур.	Max.	Unit	Waveform diagram	Remarks
Readout clock voltage	Vvт	14.55	15.0	15.45	V	1	
	Vvh1, Vvh2	-0.05	0	0.05	V	2	Vvн = (Vvн1 + Vvн2)/2
	Vvнз, Vvн4	-0.2	0	0.05	V	2	
	Vvl1, Vvl2, Vvl3, Vvl4	-9.6	-9.0	-8.5	V	2	$V_{VL} = (V_{VL3} + V_{VL4})/2$
	Vφv	8.3	9.0	9.65	Vp-p	2	$V\phi v = VvHn - VvLn (n = 1 to 4)$
Vertical transfer clock	Vvн1 — Vvн2			0.1	V	2	
voltage	Vvнз — Vvн	-0.25		0.1	V	2	
	Vvh4 – Vvh	-0.25		0.1	V	2	
	Vvнн			0.5	V	2	High-level coupling
	Vvhl			0.5	V	2	High-level coupling
	Vvlh			0.5	V	2	Low-level coupling
	Vvll			0.5	V	2	Low-level coupling
Horizontal transfer	Vфн	4.75	5.0	5.25	Vp-p	3	
clock voltage	Vhl	-0.05	0	0.05	V	3	
	Vrgl		*1		V	4	
Reset gate clock voltage ^{*1}	Vørg	4.5	5.0	5.5	Vp-p	4	
	Vrglh – Vrgll			0.8	V	4	Low-level coupling
Substrate clock voltage	Vфsuв	23.0	24.0	25.0	Vp-p	5	

*1 Input the reset gate clock without applying a DC bias. In addition, the reset gate clock can also be driven with the following specifications.

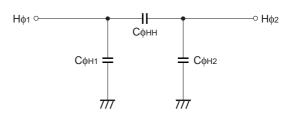
Item	Symbol	Min.	Тур.	Max.	Unit	Waveform diagram	Remarks
Reset gate clock	Vrgl	-0.2	0	0.2	V	4	
voltage	Vørg	8.5	9.0	9.5	Vp-p	4	

Clock Equivalent Circuit Constant

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
Capacitance between vertical transfer clock	Cφν1, Cφν3		2700		pF	
and GND	Cφν2, Cφν4		2700		pF	
Capacitance between vertical transfer clocks	Сфv12, Сфv34		820		pF	
Capacitance between vertical transier clocks	Сфv23, Сфv41		330		pF	
Capacitance between horizontal transfer clock	Сфн1		100		pF	
and GND	Сфн2		91		pF	
Capacitance between horizontal transfer clocks	Сфнн		47		pF	
Capacitance between reset gate clock and GND	Cørg		11		pF	
Capacitance between substrate clock and GND	Сфѕив		680		pF	
Vertical transfer clock series resistor	R1, R3		91		Ω	
	R2, R4		100		Ω	
Vertical transfer clock ground resistor	Rgnd		68		Ω	



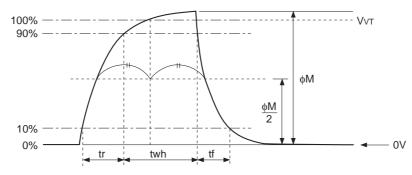
Vertical transfer clock equivalent circuit



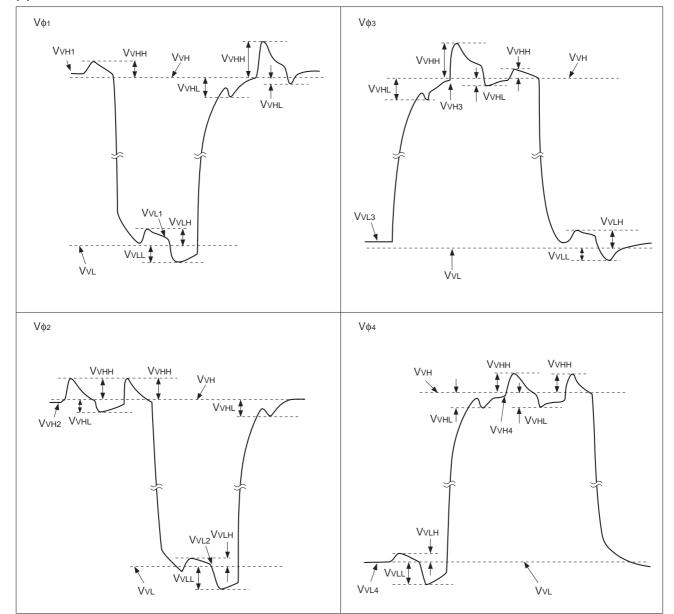
Horizontal transfer clock equivalent circuit

Drive Clock Waveform Conditions

(1) Readout clock waveform

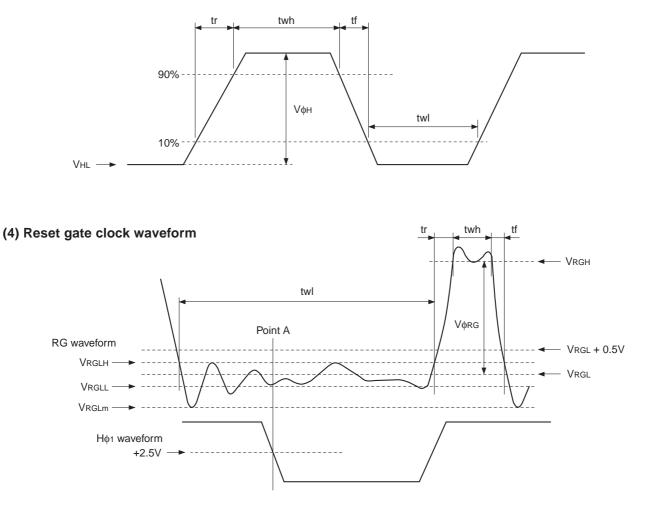






$$\begin{split} V_{VH} &= (V_{VH1} + V_{VH2})/2 \\ V_{VL} &= (V_{VL3} + V_{VL4})/2 \\ V_{\varphi V} &= V_{VHN} - V_{VLN} \ (n = 1 \ to \ 4) \end{split}$$

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VRGLH is the maximum value and VRGLL is the minimum value of the coupling waveform during the period from Point A in the above diagram until the rising edge of RG. In addition, VRGL is the average value of VRGLH and VRGLL.

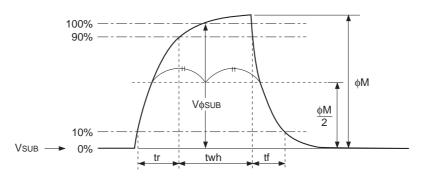
VRGL = (VRGLH + VRGLL)/2

Assuming VRGH is the minimum value during the period twh, then:

Vørg = Vrgh – Vrgl

Negative overshoot level during the falling edge of RG is VRGLm.

(5) Substrate clock waveform



Clock Switching Characteristics

	ltom	Symbol		twh			twl			tr			tf		Unit	Domorko
	Item	Symbol	Min.	Тур.	Max.	Unit	Remarks									
Rea	adout clock	Vт	2.3	2.5					0.5			0.5			μs	During readout
Ver cloc	tical transfer k	Vφ1, Vφ2, Vφ3, Vφ4										15		250	ns	*1
Horizontal transfer clock	During imaging	Ηφ		20			20			15	19		15	19	ns	*2
rizon 1sfer	During	Ηφ1		5.38						0.01			0.01			
Ho	parallel-serial conversion	Ηφ2					5.38			0.01			0.01		μs	
Res	set gate clock	φRG	11	13			51			3			3		ns	
Sub	ostrate clock	фѕив	1.5	1.8							0.5			0.5	μs	When draining charge

*1 When vertical transfer clock driver CXD1267AN is used.

*2 tf \geq tr - 2ns.

ltom	Symbol		two		Linit	Domorko	
Item	Symbol	Min.	Тур.	Max.	Unit	Remarks	
Horizontal transfer clock	Ηφ1, Ηφ2	16	20		ns	*3	

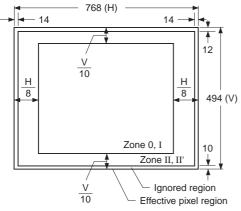
*3 The overlap period for twh and twl of horizontal transfer clocks $H\phi_1$ and $H\phi_2$ is two.

 $(Ta = 25^{\circ}C)$

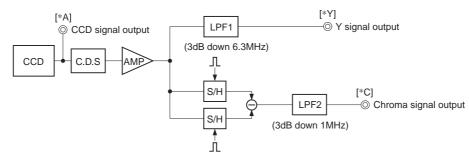
Image Sensor Characteristics

Item	Symbol	Min.	Тур.	Max.	Unit	Measurement method	Remarks
Sensitivity	S	1040	1300		mV	1	
Saturation signal	Ysat	1000			mV	2	Ta = 60°C
Smear	Sm		-115	-105	dB	3	
	CHV			20	%	4	Zone 0 and I
Video signal shading	SHy			25	%	4	Zone 0 to II'
Uniformity between	∆Sr			10	%	5	
video signal channels	∆Sb			10	%	5	
Dark signal	Ydt			2	mV	6	Ta = 60°C
Dark signal shading	ΔYdt			1	mV	7	Ta = 60°C
Flicker Y	Fy			2	%	8	
Flicker R-Y	Fcr			5	%	8	
Flicker B-Y	Fcb			5	%	8	
Line crawl R	Lcr			3	%	9	
Line crawl G	Lcg			3	%	9	
Line crawl B	Lcb			3	%	9	
Line crawl W	Lcw			3	%	9	
Lag	Lag			0.5	%	10	

Zone Definition of Video Signal Shading



Measurement System



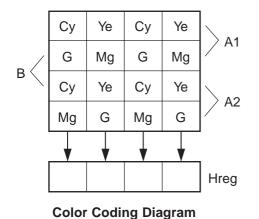
Note) Adjust the amplifier gain so that the gain between [*A] and [*Y], and between [*A] and [*C] equals 1.

Image Sensor Characteristics Measurement Method

○ Measurement conditions

- 1) In the following measurements, the device drive conditions are at the typical values of the bias and clock voltage conditions. (when used with substrate bias external adjustment, set the substrate voltage to the value indicated on the device.)
- 2) In the following measurements, spot blemishes are excluded and, unless otherwise specified, the optical black level (OB) is used as the reference for the signal output, which is taken as the value of Y signal output or chroma signal output of the measurement system.

© Color coding of this image sensor & Composition of Iuminance (Y) and chroma (color difference) signals



As shown in the left figure, fields are read out. The charge is mixed by pairs such as A1 and A2 in the A field. (pairs such as B in the B field)

As a result, the sequence of charges output as signals from the horizontal shift register (Hreg) is, for line A1, (G + Cy), (Mg + Ye), (G + Cy), and (Mg + Ye).

These signals are processed to form the Y signal and chroma (color difference) signal. The Y signal is formed by adding adjacent signals, and the chroma signal is formed by subtracting adjacent signals. In other words, the approximation:

$$Y = \{(G + Cy) + (Mg + Ye)\} \times 1/2$$

= 1/2 {2B + 3G + 2R}

is used for the Y signal, and the approximation:

$$R - Y = \{(Mg + Ye) - (G + Cy)\}\$$

= {2R - G}

is used for the chroma (color difference) signal. For line A2, the signals output from Hreg in sequence are

$$Mg + Cy$$
, $(G + Ye)$, $(Mg + Cy)$, $(G + Ye)$.

The Y signal is formed from these signals as follows:

$$Y = \{(G + Ye) + (Mg + Cy)\} \times 1/2$$

This is balanced since it is formed in the same way as for line A1.

In a like manner, the chroma (color difference) signal is approximated as follows:

$$-(B - Y) = \{(G + Ye) - (Mg + Cy)\}\$$

= $-\{2B - G\}$

In other words, the chroma signal can be retrieved according to the sequence of lines from R - Y and -(B - Y) in alternation. This is also true for the B field.

◎ Definition of standard imaging conditions

1) Standard imaging condition I:

Use a pattern box (luminance 706cd/m², color temperature of 3200K halogen source) as a subject. (Pattern for evaluation is not applicable.) Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter and image at F5.6. The luminous intensity to the sensor receiving surface at this point is defined as the standard sensitivity testing luminous intensity.

2) Standard imaging condition II:

Image a light source (color temperature of 3200K) with a uniformity of brightness within 2% at all angles. Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

1. Sensitivity

Set to standard imaging condition I. After selecting the electronic shutter mode with a shutter speed of 1/250s, measure the Y signal (Ys) at the center of the screen and substitute the value into the following formula.

$$S = Ys \times \frac{250}{60} [mV]$$

2. Saturation signal

Set to standard imaging condition II. After adjusting the luminous intensity to 10 times the intensity with average value of the Y signal output, 200mV, measure the minimum value of the Y signal.

3. Smear

Set to standard imaging condition II. With the lens diaphragm at F5.6 to F8, adjust the luminous intensity to 500 times the intensity with average value of the Y signal output, 200mV. When the readout clock is stopped and the charge drain is executed by the electronic shutter at the respective H blankings, measure the maximum value YSm [mV] of the Y signal output and substitute the value into the following formula.

Sm =
$$20 \times \log \left(\frac{YSm}{200} \times \frac{1}{500} \times \frac{1}{10}\right)$$
 [dB] (1/10V method conversion value)

4. Video signal shading

Set to standard imaging condition II. With the lens diaphragm at F5.6 to F8, adjust the luminous intensity so that the average value of the Y signal output is 200 mV. Then measure the maximum (Ymax [mV]) and minimum (Ymin [mV]) values of the Y signal and substitute the values into the following formula.

 $SHy = (Ymax - Ymin)/200 \times 100 [\%]$

5. Uniformity between video signal channels

Set to standard imaging condition II. Adjust the luminous intensity so that the average value of the Y signal output is 200mV, and then measure the maximum (Crmax, Cbmax [mV]) and minimum (Crmin, Cbmin [mV]) values of the R – Y and B – Y channels of the chroma signal and substitute the values into the following formula.

 $\Delta Sr = | (Crmax - Crmin)/200 | \times 100 [\%]$ $\Delta Sb = | (Cbmax - Cbmin)/200 | \times 100 [\%]$

6. Dark signal

Measure the average value of the Y signal output (Ydt [mV]) with the device ambient temperature 60°C and the device in the light-obstructed state, using the horizontal idle transfer level as a reference.

7. Dark signal shading

After measuring 6, measure the maximum (Ydmax [mV]) and minimum (Ydmin [mV]) values of the dark signal output and substitute the values into the following formula.

 Δ Ydt = Ydmax - Ydmin [mV]

8. Flicker

1) Fy

Set to standard imaging condition II. Adjust the luminous intensity so that the average value of the Y signal output is 200mV, and then measure the difference in the signal level between fields (Δ Yf [mV]). Then substitute the value into the following formula.

 $Fy = (\Delta Yf/200) \times 100 [\%]$

2) Fcr, Fcb

Set to standard imaging condition II. Adjust the luminous intensity so that the average value of the Y signal output is 200mV, insert an R or B filter, and then measure both the difference in the signal level between fields of the chroma signal (Δ Cr, Δ Cb) as well as the average value of the chroma signal output (CAr, CAb). Substitute the values into the following formula.

 $Fci = (\Delta Ci/CAi) \times 100 [\%]$ (i = r, b)

9. Line crawls

Set to standard imaging condition II. Adjust the luminous intensity so that the average value of the Y signal output is 200mV, and then insert a white subject and R, G, and B filters and measure the difference between Y signal lines for the same field (Δ YIw, Δ YIr, Δ YIg, Δ YIb [mV]). Substitute the values into the following formula.

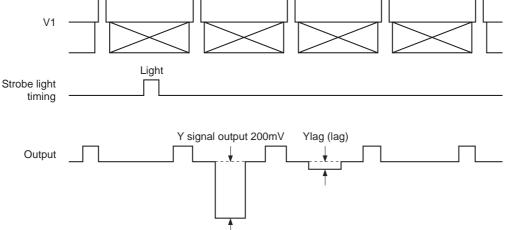
 $Lci = (\Delta Y li/200) \times 100 [\%]$ (i = w, r, g, b)

Lag = (Ylag/200) × 100 [%]

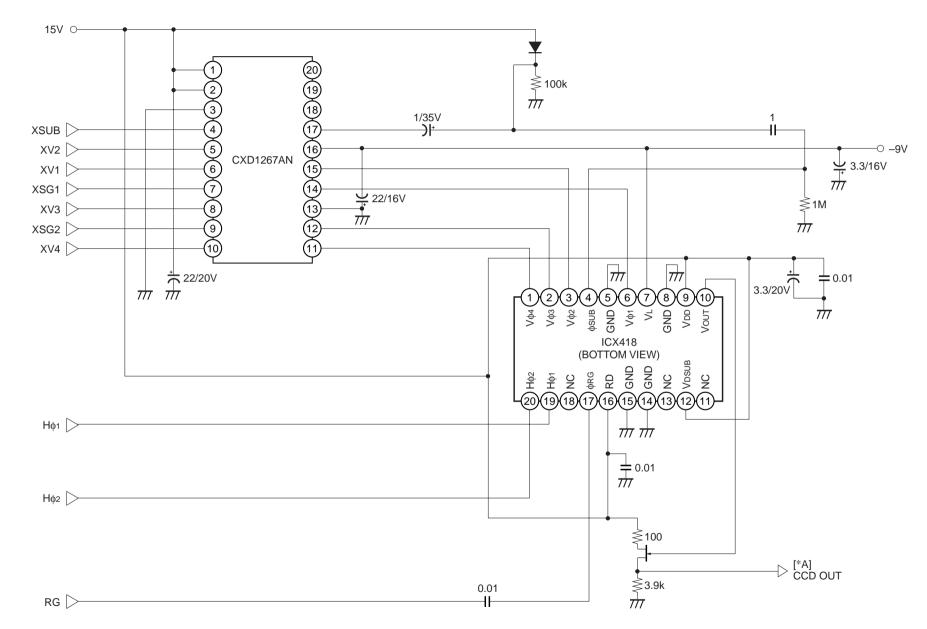
10. Lag

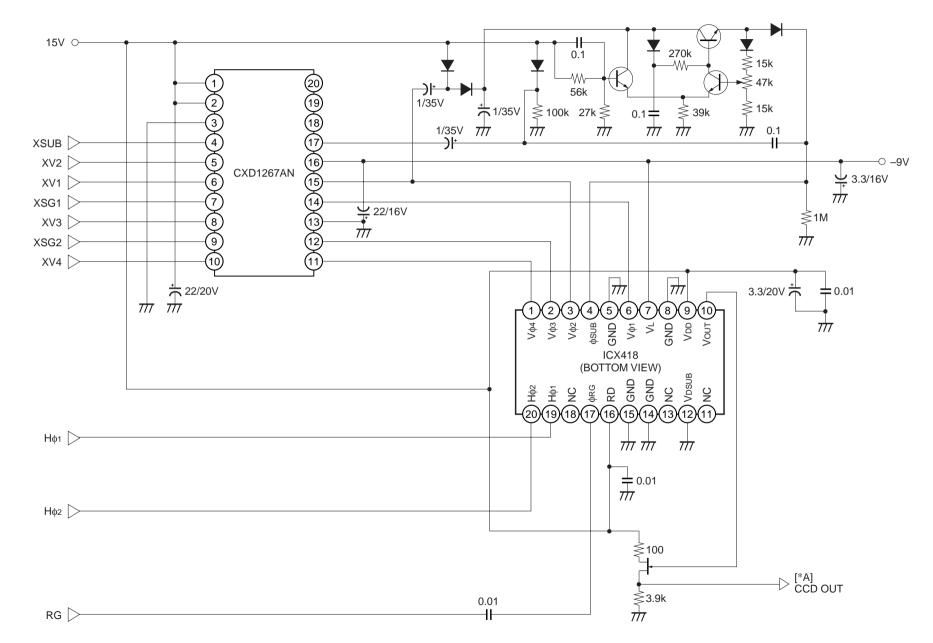
Adjust the Y signal output value generated by strobe light to 200mV. After setting the strobe light so that it strobes with the following timing, measure the residual signal (Ylag). Substitute the value into the following formula.

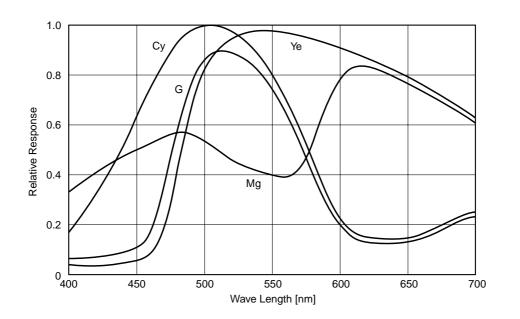




Drive Circuit 1 (substrate bias internal generation mode)

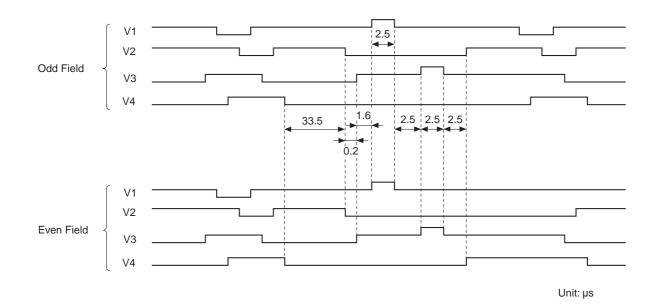


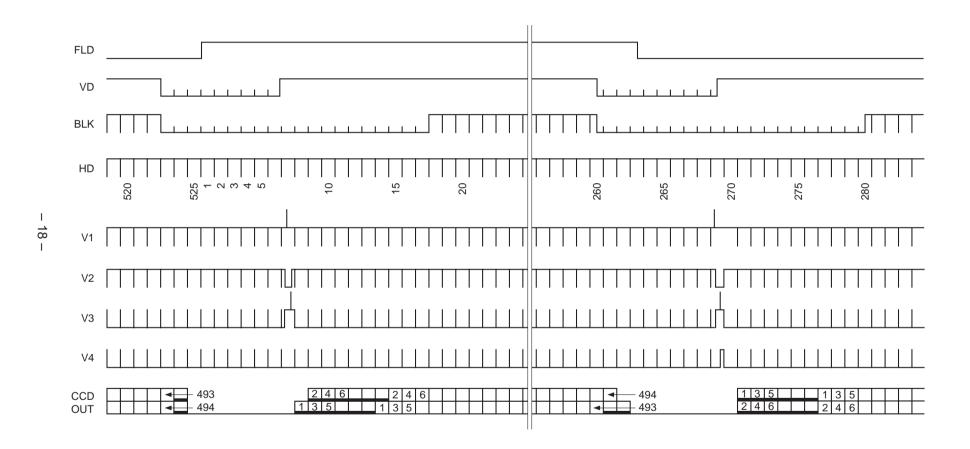


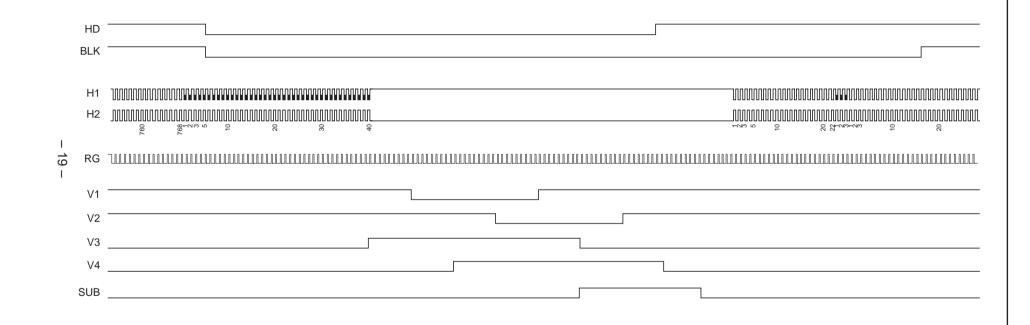


Spectral Sensitivity Characteristics (Excludes lens characteristics and light source characteristics)

Sensor Readout Clock Timing Chart







Notes on Handling

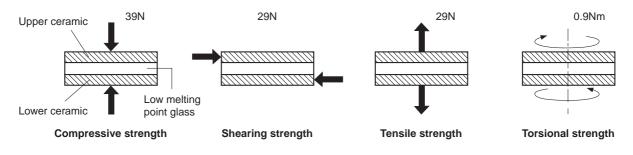
1) Static charge prevention

CCD image sensors are easily damaged by static discharge. Before handling be sure to take the following protective measures.

- a) Either handle bare handed or use non-chargeable gloves, clothes or material.
 - Also use conductive shoes.
- b) When handling directly use an earth band.
- c) Install a conductive mat on the floor or working table to prevent the generation of static electricity.
- d) Ionized air is recommended for discharge when handling CCD image sensor.
- e) For the shipment of mounted substrates, use boxes treated for the prevention of static charges.
- 2) Soldering
 - a) Make sure the package temperature does not exceed 80°C.
 - b) Solder dipping in a mounting furnace causes damage to the glass and other defects. Use a ground 30W soldering iron and solder each pin in less than 2 seconds. For repairs and remount, cool sufficiently.
 - c) To dismount an image sensor, do not use a solder suction equipment. When using an electric desoldering tool, use a thermal controller of the zero cross On/Off type and connect it to ground.
- 3) Dust and dirt protection

Image sensors are packed and delivered by taking care of protecting its glass plates from harmful dust and dirt. Clean glass plates with the following operation as required, and use them.

- a) Perform all assembly operations in a clean room (class 1000 or less).
- b) Do not either touch glass plates by hand or have any object come in contact with glass surfaces. Should dirt stick to a glass surface, blow it off with an air blower. (For dirt stuck through static electricity ionized air is recommended.)
- c) Clean with a cotton bud and ethyl alcohol if the grease stained. Be careful not to scratch the glass.
- d) Keep in a case to protect from dust and dirt. To prevent dew condensation, preheat or precool when moving to a room with great temperature differences.
- e) When a protective tape is applied before shipping, just before use remove the tape applied for electrostatic protection. Do not reuse the tape.
- 4) Installing (attaching)
 - a) Remain within the following limits when applying a static load to the package. Do not apply any load more than 0.7mm inside the outer perimeter of the glass portion, and do not apply any load or impact to limited portions. (This may cause cracks in the package.)



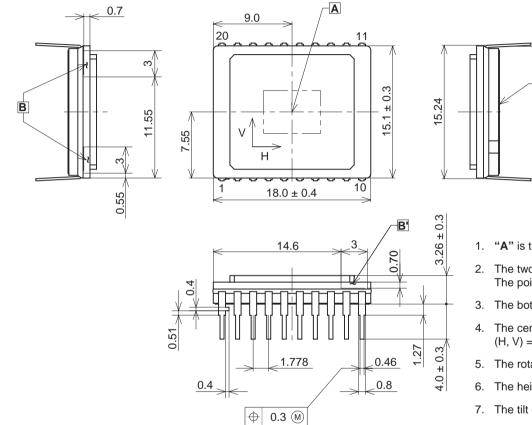
b) If a load is applied to the entire surface by a hard component, bending stress may be generated and the package may fracture, etc., depending on the flatness of the ceramic portions. Therefore, for installation, use either an elastic load, such as a spring plate, or an adhesive.

- c) The adhesive may cause the marking on the rear surface to disappear, especially in case the regulated voltage value is indicated on the rear surface. Therefore, the adhesive should not be applied to this area, and indicated values should be transferred to other locations as a precaution.
- d) The upper and lower ceramic are joined by low melting point glass. Therefore, care should be taken not to perform the following actions as this may cause cracks.
 - Applying repeated bending stress to the outer leads.
 - Heating the outer leads for an extended period with a soldering iron.
 - Rapidly cooling or heating the package.
 - Applying any load or impact to a limited portion of the low melting point glass using tweezers or other sharp tools.
 - Prying at the upper or lower ceramic using the low melting point glass as a fulcrum.
 - Note that the same cautions also apply when removing soldered products from boards.
- e) Acrylate anaerobic adhesives are generally used to attach CCD image sensors. In addition, cyanoacrylate instantaneous adhesives are sometimes used jointly with acrylate anaerobic adhesives. (reference)

5) Others

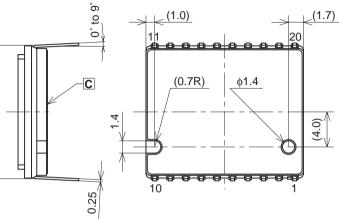
- a) Do not expose to strong light (sun rays) for long periods, color filters will be discolored. When high luminance objects are imaged with the exposure level control by electronic-iris, the luminance of the image-plane may become excessive and discolor of the color filter will possibly be accelerated. In such a case, it is advisable that taking-lens with the automatic-iris and closing of the shutter during the power-off mode should be properly arranged. For continuous using under cruel condition exceeding the normal using condition, consult our company.
- b) Exposure to high temperature or humidity will affect the characteristics. Accordingly avoid storage or usage in such conditions.

20pin DIP (600mil)



PACKAGE STRUCTURE

Cer-DIP
TIN PLATING
42 ALLOY
2.6g
AS-B14-01(E)



- 1. "A" is the center of the effective image area.
- 2. The two points "**B**" of the package are the horizontal reference. The point "**B**" of the package is the vertical reference.
- 3. The bottom "C" of the package is the height reference.
- 4. The center of the effective image area, relative to "**B**" and "**B**" is $(H, V) = (9.0, 7.55) \pm 0.15$ mm.
- 5. The rotation angle of the effective image area relative to H and V is $\pm 1^{\circ}$.
- 6. The height from the bottom "C" to the effective image area is 1.41 ± 0.15 mm.
- 7. The tilt of the effective image area relative to the bottom "C" is less than 60µm.
- 8. The thickness of the cover glass is 0.75mm, and the refractive index is 1.5.
- 9. The notch and the hole on the bottom must not be used for reference of fixing.